# Status of the Front Tracker GEM and MAROC readout for PMTs

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2013 –December– 04 SBS Weekly Meeting

INFN - Catania, Genova, Bari and Rome/Sanità

Started assembling with new GEM foil revision

Electronics test for final production

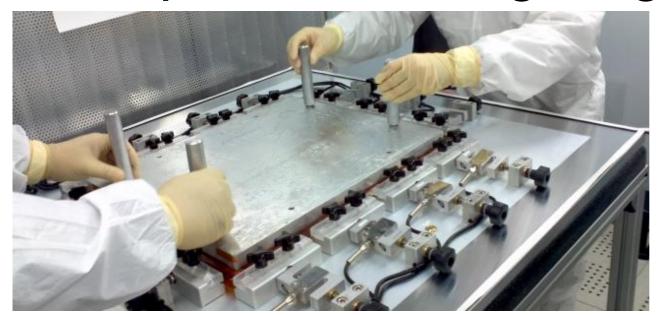
MAROC readout for PMTs...

# Summary of activities

#### Last few weeks mainly devoted to:

- Going to finalize the cosmic test infrastructure for the GEM modules in Rome
- Move to the assembling of the new GEM foil (with external protective resistors) ... Needs some changes in the HV testing tools and assembling procedures
- Starting test of the final MPDs
- Tested latest (different APV25 bonding) Front End cards for starting final production
- Finalizing the testing procedures (and related software)

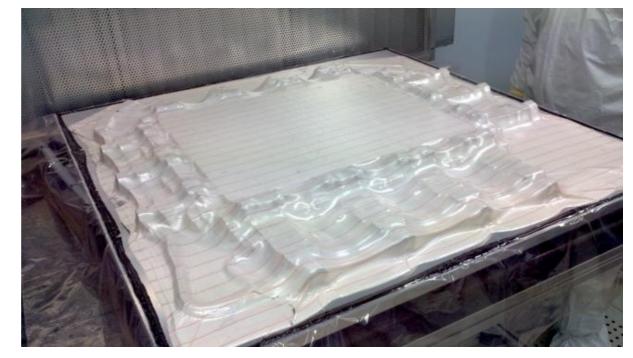
# Improved GEM gluing procedure



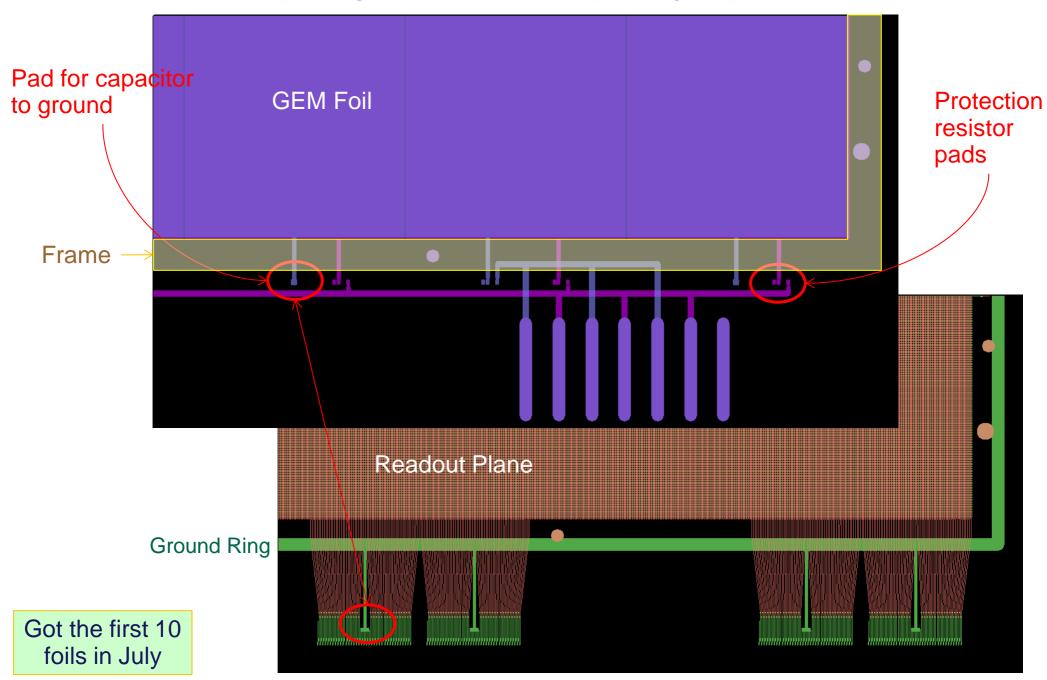
Use vacuum to make uniform pressure and improve glue degassing

Used for readout foil glued on honeycomb and GEM on frame ... 24 h each

Assembling procedures detailed document under finalization

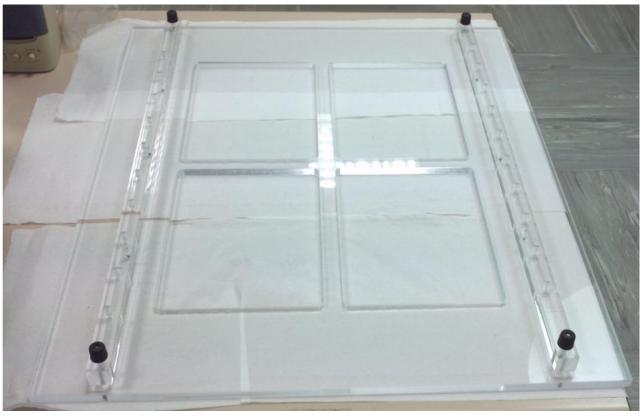


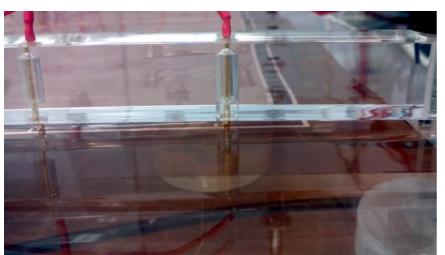
#### New GEM foil revision / detail



# New HV GEM Testbed

Test bed open to permit dust falling

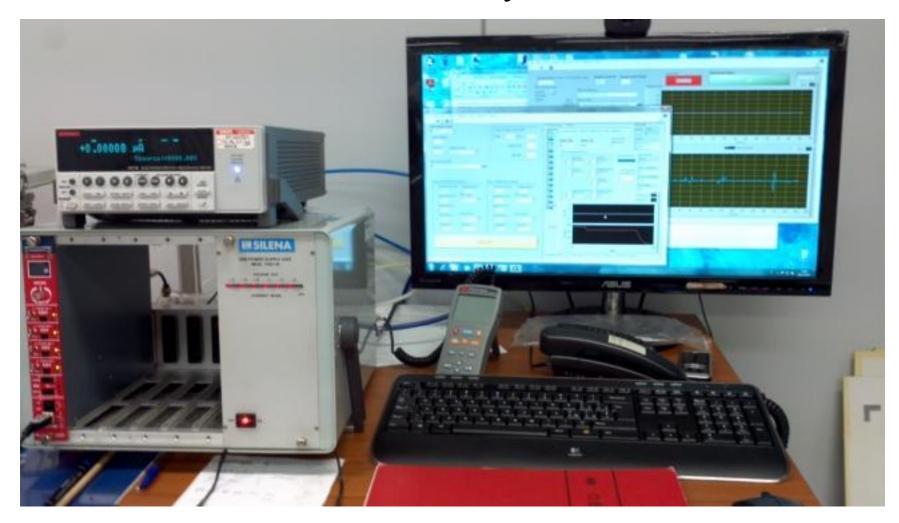




Precise pins fixed locations to avoid misaligment and bad contact (use the reference holes in GEM)

# Improved LabView Control

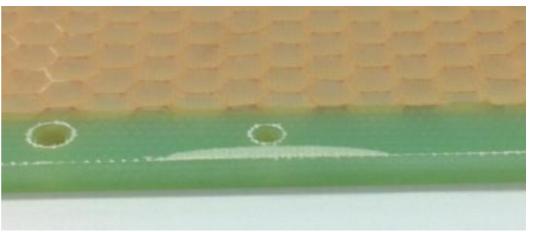
All settings and readings during HV test are now stored on files automatically



# Some production issues

Honeycomb plane:

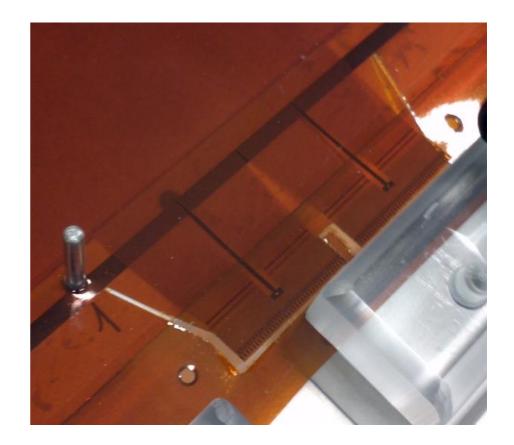
Upper layer tends to un-glue in few points on last 2 planes inspected



Readout cutting quality on last bunch of production:

Moved from laser cutting to «standard» cutting

Seems to be minor or no issue -> to be checked after assembling with electronics



## **Electronics Test and Production**

#### MPD VME Modules

All produced and delivered; first 4 tested successfully (testing procedure basically completed: test report for each MPD)

#### Front-End

Latest tuning before final production: modified bonding procedure and bonding pads to improve quality (?) and speed up production.

New 5 cards received; two of them tested successfully, additional three show problem likely related to heating temperature during bonding ... confirmation underway

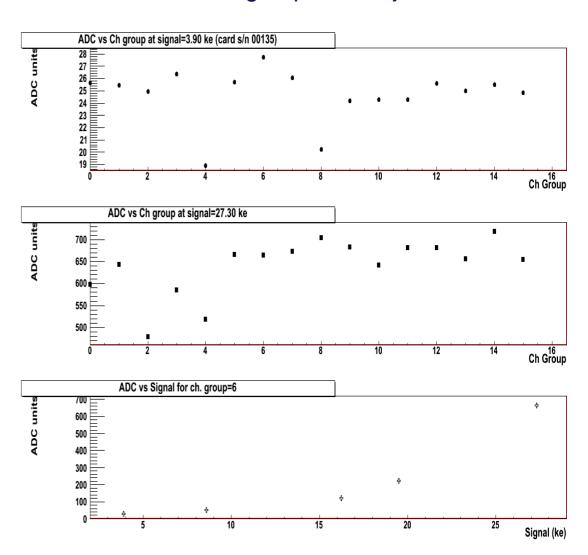
Testing procedure under finalization: test report for each of approx. 400 cards

## Front End Test Procedure

#### Test procedure

- 1. Absorbed current
- 2. ADC levels
- 3. Pedestal and noise level disconnected and after connection to test board (via flat adapter)
- 4. Internal calibration pulse estimate gain ch by ch
- External calibration pulse estimate gain and quality of bonding contacts ch by ch

External pulse on 2 pF capacitor connected to software selectable group of 8 adjacent channels



## MAROC electronics for PMTs

Following some discussions on the possibility to use the MAROC electronics for the PMTs in SBS

Few years ago we developed a MAROC2/3 based electronics for medical application (many optical photons regime)

We made several tests in the last few months to study the Single PhotoElectron response

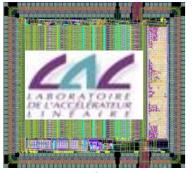
We are going to modify the above electronics for the new CLAS12 RICH detectors (single optical photon regime)

# MAROC (Multi Anode Read Out Chip)

Single Channel (x64)

channels

Originally designed for ATLAS



•240-pin

•16 mm<sup>2</sup>

Preamplifier, configurable (gain 8 bit)

★Fast line: 25 ns shaper + discriminator ⇒ Binary datum

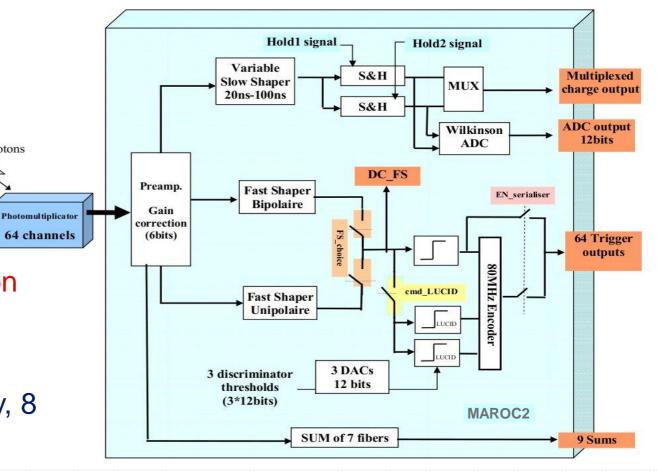
★Slow line: 100 ns shaper + mem. cell + ADC ⇒ Analog charge

★ Prompt Sum line: send to one of 8 embedded sum output

PROs: 64 chs, designed for MAPMT, existing expertise, low power

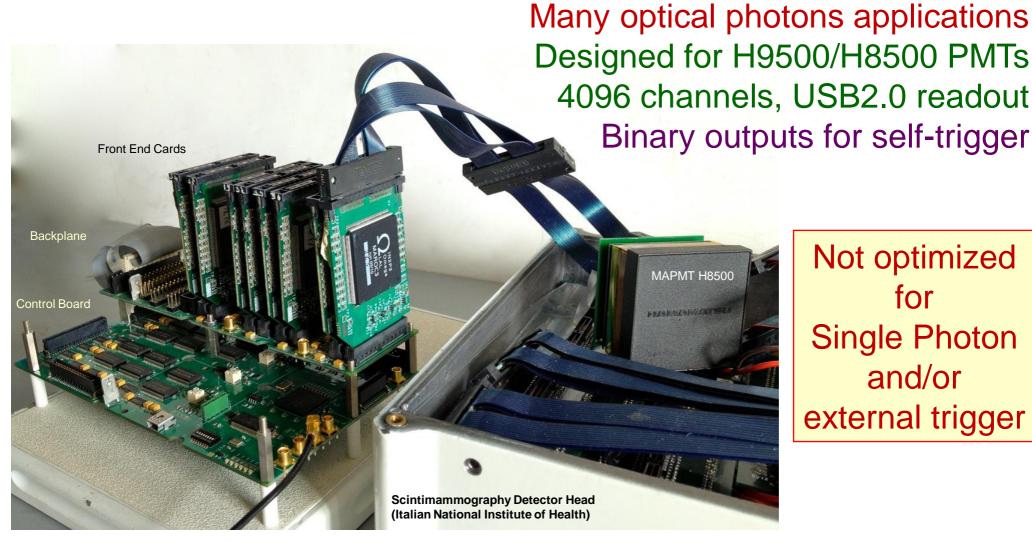
CONs: Analog limited latency, 64 channels single channel time resolution few ns (not true, see next)

Outputs: 1 Analog (MUX), 1 digitalized charge, 64 Binary, 8 prompt analog sums



### In House MAROC based DAQ

Original system developed for Medical Imaging with radionuclides



Not optimized for Single Photon and/or external trigger

Modular design (FrontEnd + Bus + ControlBoard + USB int.)

## MAROC - Single Photo Electron Level

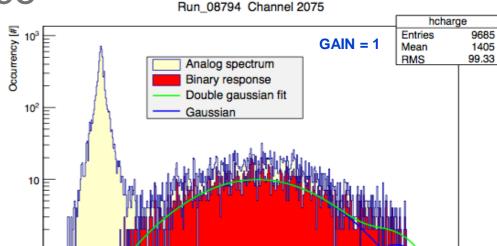
External trigger / Light Source

# Clean SPE identification with binary data (red)

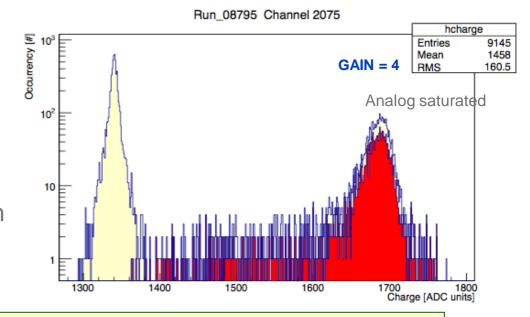
The smooth cut observed in the analog distributions can originate from:

- noise (both analog and binary combined)
- binary line provides better information on single photoelectron and «sees» good event below analog pedestal

Analog-binary amplitude mismatch due to not-optimal relative synchronization between analog and binary outputs (next slide)



Analog Timing: First local maximum

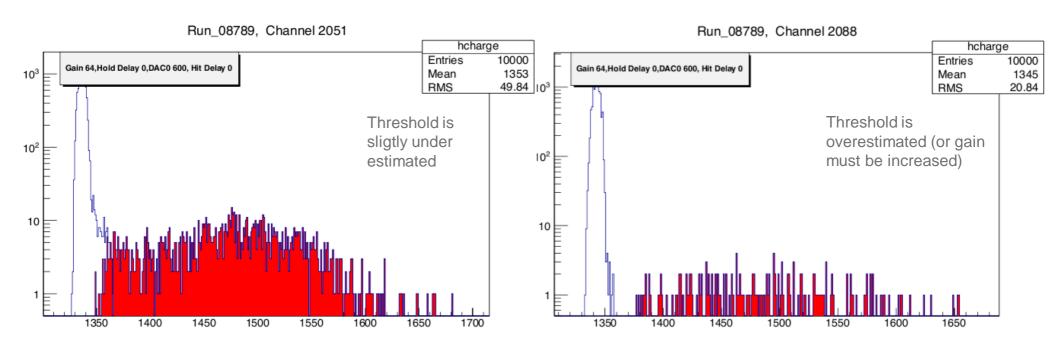


Binary output behaves as well as analog (or even better)

0 1700 1750 Charge [ADC units]

# MAROC - Gain Equalization

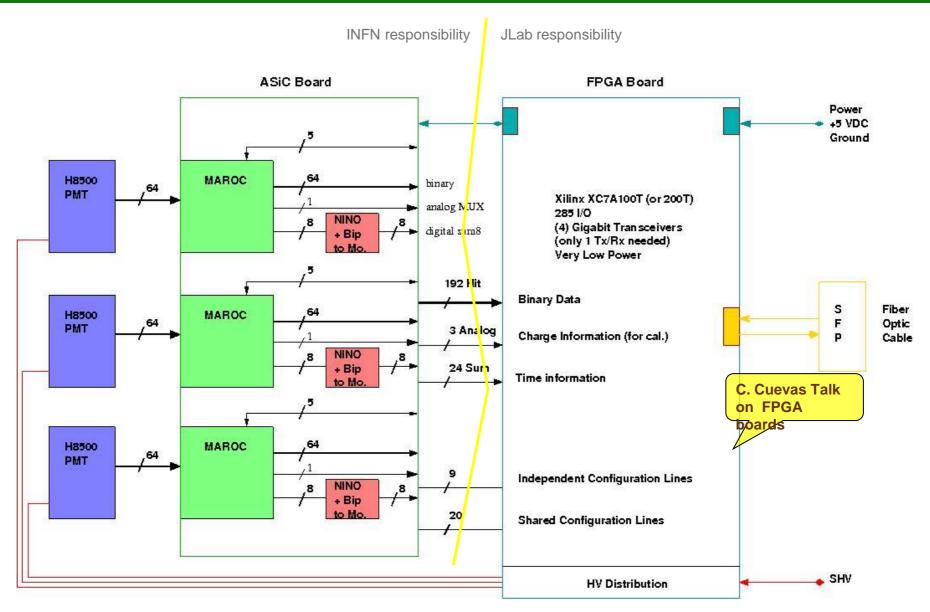
**Self-trigger** capability can be exploited for effective calibration (gain equalization, threshold selection, MAPMT gain compensation)



Dark spectra for two different channels

The small dark count rate (10Hz) is quickly acquired in self trigger mode, while in external trigger would require either a long acquisition time or an external light source.

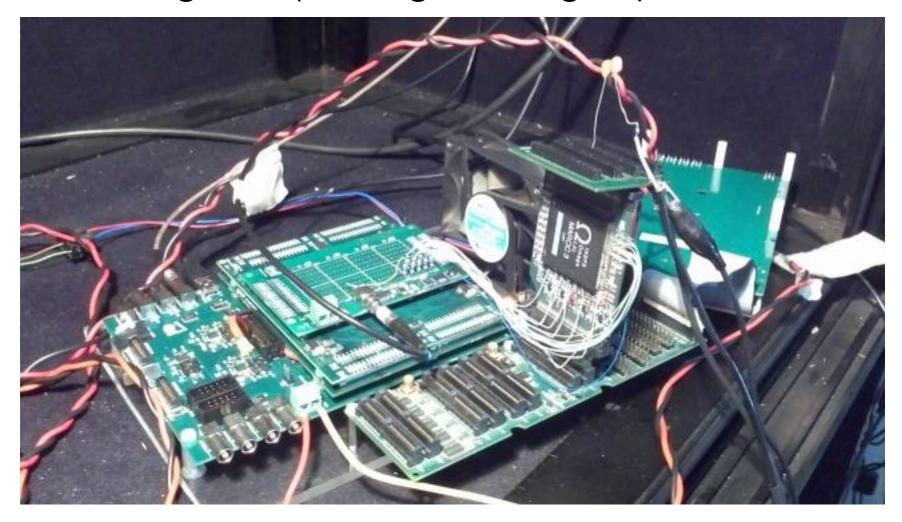
### CLAS12 RICH - DAQ electronics



Modular design with 3 logic/physical layers (similar approach of the existing electronics ⇒ straightforward porting)

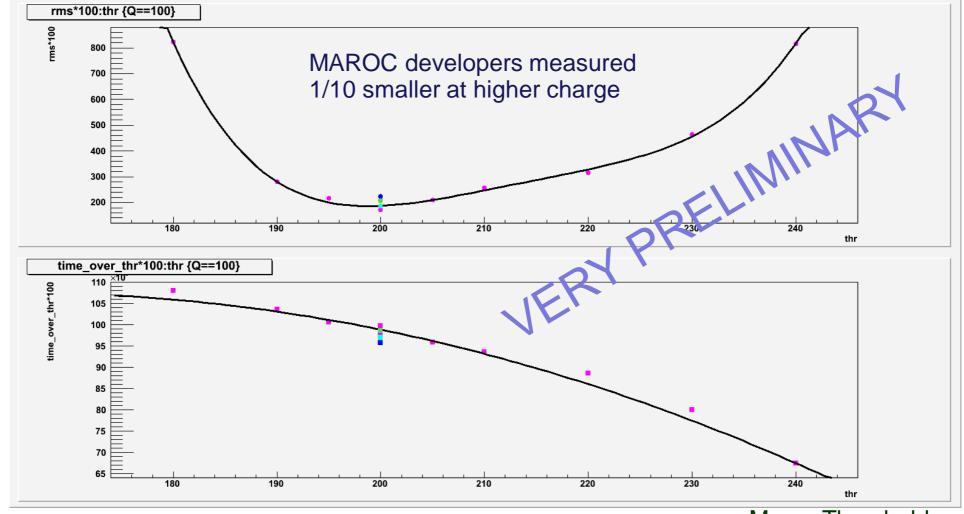
### MAROC-NINO Interface

Used to measure the time performance of the MAROC signals (analog and digital)



# SPE MAROC Timing Resolution

- External pulse on MAROC input at the single photoelectron level
- Measured time resolution of about 200 ps (digital MAROC output)
- Get also some information on deposited charge (Time over threshold)



(MAROC can be used in the online trigger)

Maroc Threshold

Time (ps)

Time Over Thr (ps)